



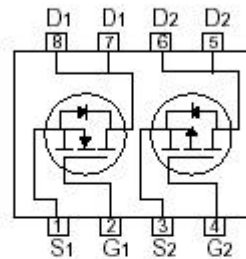
CEM9952A

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Dual Enhancement Mode Field Effect Transistor(N and P Channel)

FEATURES

- ◆ 30V , 3.7A , $R_{DS(on)}=80m\Omega$ @ $V_{GS}=10V$,
 $R_{DS(on)}=110m\Omega$ @ $V_{GS}=4.5V$,
 -30V , -2.9A , $R_{DS(on)}=100m\Omega$ @ $V_{GS}=-10V$,
 $R_{DS(on)}=150m\Omega$ @ $V_{GS}=-4.5V$.
- ◆ Super high dense cell design for extremely low $R_{DS(on)}$.
- ◆ High power and current handling capability.
- ◆ Surface Mount Package.



ABSOLUTE MAXIMUM RATINGS (TA=25°C unless otherwise noted)

Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V_{DS}	30	-30	V
Gate-Source Voltage	V_{GS}	±20	±20	V
Drain Current-Continuous ¹ @ $T_J=125^\circ C$ -Pulsed ¹	I_D	±3.7	±2.9	A
	I_{DM}	±15	±10	A
Drain-Source Diode Forward Current ¹	I_S	1.2	-1.2	A
Maximum Power Dissipation ¹	P_D	2		W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ¹	$R_{\theta JA}$	62.5	°C/W
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N-Channel ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

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Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=24V, V_{GS}=0V$			1	μA
Gate-Body Leakage	I_{GSS}	$V_{DS}=\pm 20V, V_{GS}=0V$			± 100	nA
ON CHARACTERISTICS^b						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	1.6	3	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 1.0A$		60	80	n Ω
		$V_{GS} = 4.5V, I_D = 0.5A$		83	110	n Ω
On-State Drain Current	$I_D(on)$	$V_{DS} = 5V, V_{GS} = 10V$	15			A
Forward Transconductance	g_{FS}	$V_{DS} = 15V, I_D = 3.7A$	3	5		S
DYNAMIC CHARACTERISTICS^c						
Input Capacitance	C_{ISS}	$V_{DS} = 10V, V_{GS} = 0V$ $f = 1.0MHz$		335		pF
Output Capacitance	C_{OSS}			185		pF
Reverse Transfer Capacitance	C_{RSS}			50		pF
SWITCHING CHARACTERISTICS^c						
Turn-On Delay Time	$t_{D(on)}$	$V_{DS} = 10V,$ $I_D = 1A,$ $V_{GS} = 10V,$ $R_{GS} = 6 \Omega$		18	15	ns
Rise Time	t_r			13	20	ns
Turn-Off Delay Time	$t_{D(off)}$			35	50	ns
Fall Time	t_f			5	50	ns
Total Gate Charge	Q_g	$V_{DS} = 10V, I_D = 3.7A,$ $V_{GS} = 10V$		8.5	11	nC
Gate-Source Charge	Q_{GS}			1.5		nC
Gate-Drain Charge	Q_{GD}			1.8		nC

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P-Channel ELECTRICAL CHARACTERISTICS (TA=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-24V, V_{GS}=0V$			-1	μA
Gate-Body Leakage	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			± 100	nA
ON CHARACTERISTICS^b						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.5	-3	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -1A$		63	100	n Ω
		$V_{GS} = -4.5V, I_D = -0.5A$		105	150	n Ω
On-State Drain Current	$I_D(on)$	$V_{DS} = -5V, V_{GS} = -10V$	-10			A
Forward Transconductance	g_{FS}	$V_{DS} = -15V, I_D = -2.9A$	2	4.7		S
DYNAMIC CHARACTERISTICS^c						
Input Capacitance	C_{iss}	$V_{DS} = -10V, V_{GS} = 0V$ $f = 1.0MHz$		830		rF
Output Capacitance	C_{oss}			400		pF
Reverse Transfer Capacitance	C_{rss}			123		pF
SWITCHING CHARACTERISTICS^c						
Turn-On Delay Time	$t_{D(on)}$	$V_{DS} = -10V,$ $I_D = -1A,$ $V_{GS} = -10V,$ $R_{\theta GS} = 6 \Omega$		20	28	ns
Rise Time	t_r			20	28	ns
Turn-Off Delay Time	$t_{D(off)}$			37	59	ns
Fall Time	t_f			26	37	ns
Total Gate Charge	Q_g	$V_{DS} = -10V, I_D = -2.9A,$ $V_{GS} = -10V$		16	21	nC
Gate-Source Charge	Q_{gs}			2.0		nC
Gate-Drain Charge	Q_{gd}			4.0		nC

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ELECTRICAL CHARACTERISTICS ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

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Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS^b						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{V}, I_S = 1.25\text{A}$ N-Ch	0.78	1.2		V
		$V_{GS} = 0\text{V}, I_S = -1.25\text{A}$ P-Ch	-0.78	-1.2		

Notes

- a. Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.
- b. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.
- c. Guaranteed by design, not subject to production testing.

N-Channel

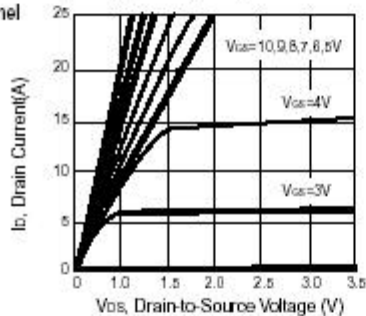


Figure 1. Output Characteristics

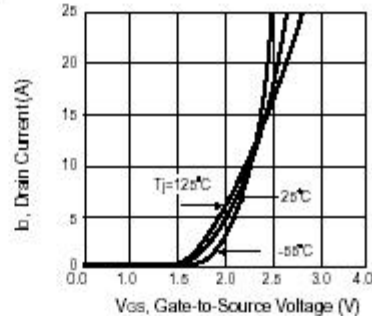


Figure 2. Transfer Characteristics

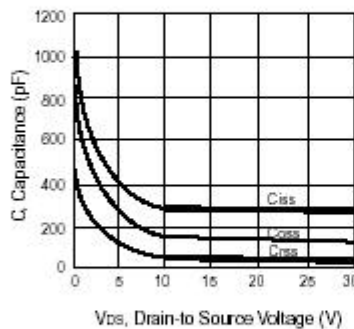


Figure 3. Capacitance

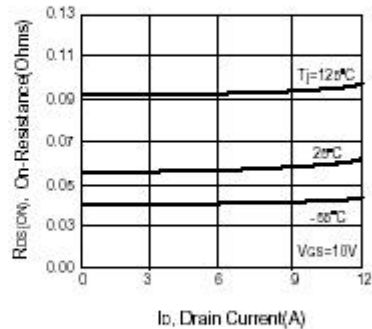


Figure 4. On-Resistance Variation with Drain Current and Temperature

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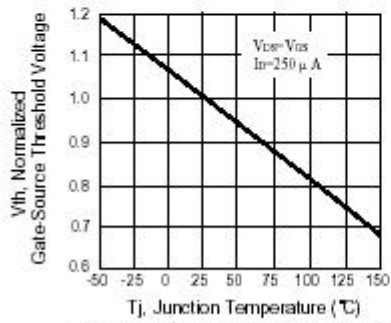


Figure 5. Gate Threshold Variation with Temperature

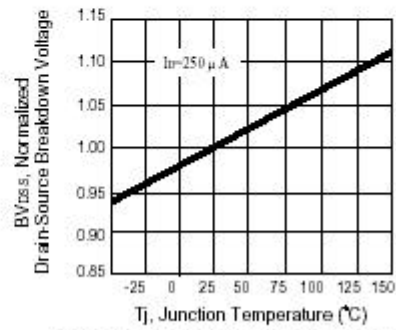


Figure 6. Breakdown Voltage Variation with Temperature

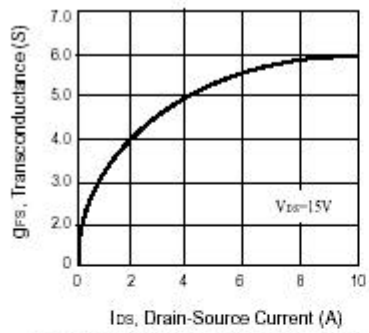


Figure 7. Transconductance Variation with Temperature

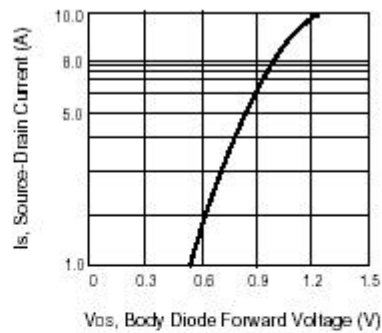


Figure 8. Body Diode Forward Voltage Variation with Source Current

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P-Channel

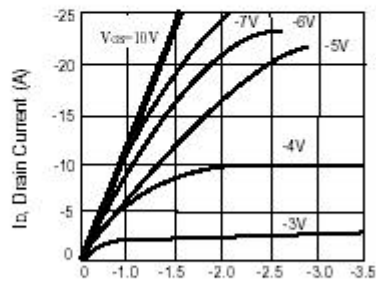


Figure 1. Output Characteristics

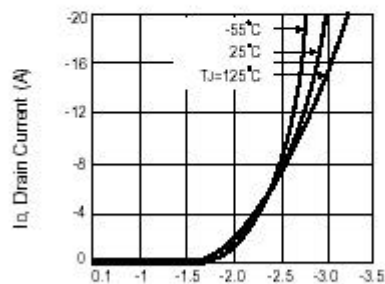


Figure 2. Transfer Characteristics

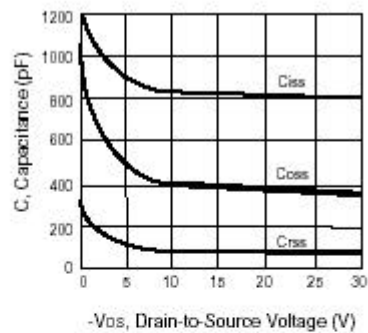


Figure 3. Capacitance

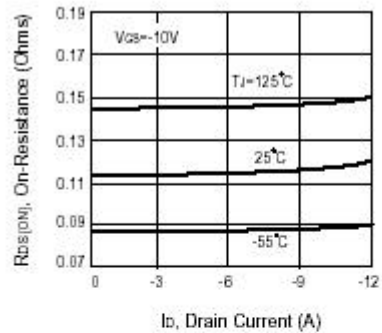
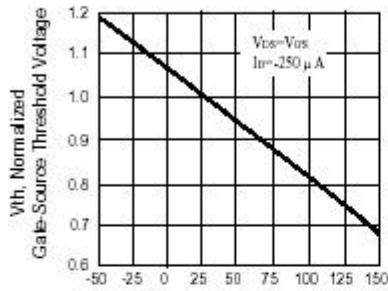


Figure 4. On-Resistance Variation with Drain Current and Temperature

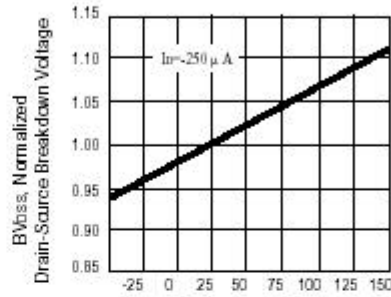
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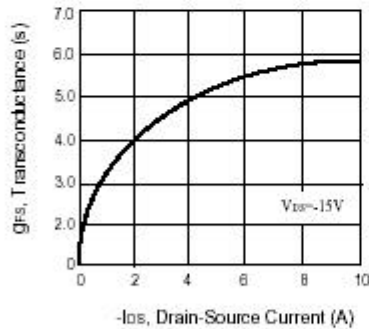
P-Channel



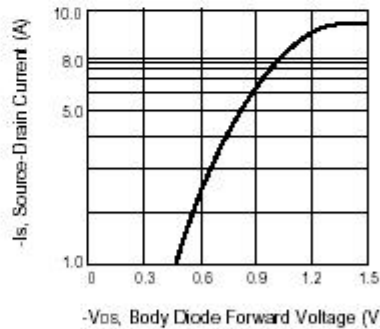
Tj, Junction Temperature (°C)
Figure 5. Gate Threshold Variation with Temperature



Tj, Junction Temperature (°C)
Figure 6. Breakdown Voltage Variation with Temperature



-IDS, Drain-Source Current (A)
Figure 7. Transconductance Variation with Temperature

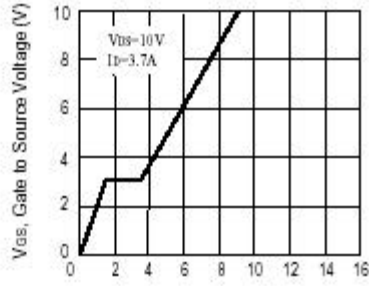


-VDS, Body Diode Forward Voltage (V)
Figure 8. Body Diode Forward Voltage Variation with Source Current

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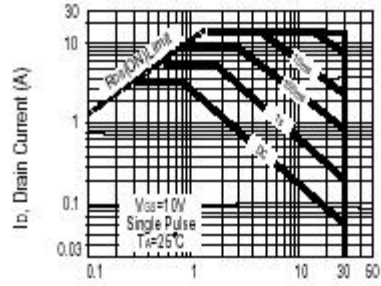
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N-Channel



Qg, Total Gate Charge (nC)

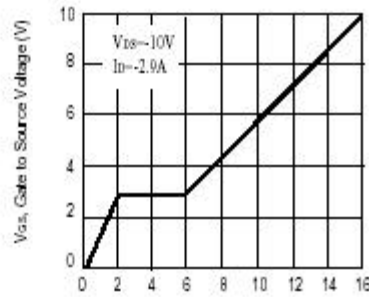
Figure 9. Gate Charge



Vds, Drain-Source Voltage (V)

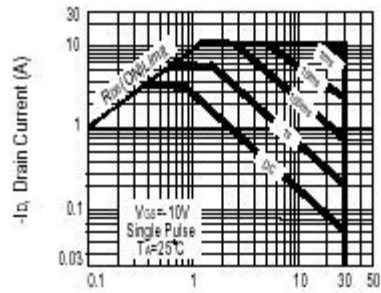
Figure 10. Maximum Safe Operating Area

P-Channel



Qg, Total Gate Charge (nC)

Figure 9. Gate Charge



-Vds, Body Diode Forward Voltage (V)

Figure 10. Maximum Safe Operating Area

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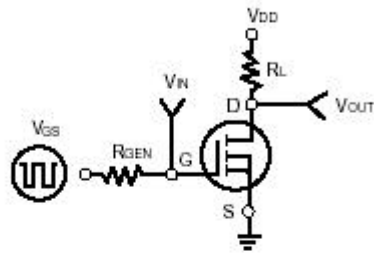


Figure 11. Switching Test Circuit

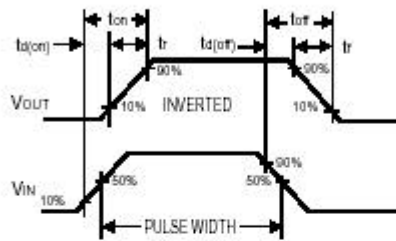


Figure 12. Switching Waveforms

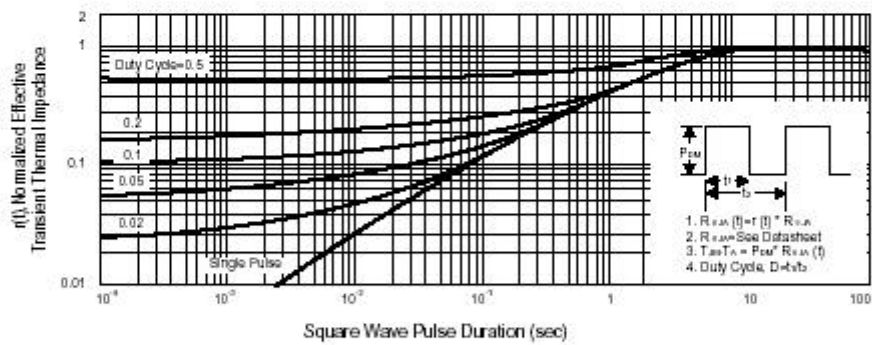


Figure 13. Normalized Thermal Transient Impedance Curve

